**TOSHIBA** 2SC3098

#### TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL PLANAR TYPE

# 2 S C 3 0 9 8

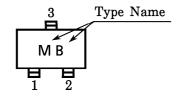
## UHF~C BAND LOW NOISE AMPLIFIER APPLICATIONS

- Low Noise Figure
- NF = 2.5 dB,  $|S_{21e}|^2 = 14.5 dB$  (f = 500MHz)
- $NF = 3.0dB, |S_{21e}|^2 = 9.0dB (f = 1GHz)$

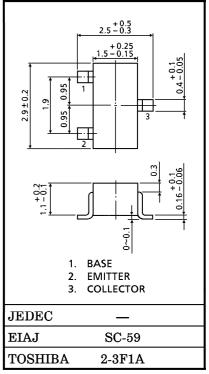
#### MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	$v_{CBO}$	30	V
Collector-Emitter Voltage	$v_{CEO}$	20	V
Emitter-Base Voltage	$ m v_{EBO}$	3	V
Collector Current	$I_{\mathbf{C}}$	50	mA
Base Current	$I_{\mathbf{B}}$	25	mA
Collector Power Dissipation	$P_{\mathbf{C}}$	150	mW
Junction Temperature	$T_{j}$	125	$^{\circ}\mathrm{C}$
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~125	$^{\circ}\mathrm{C}$

#### Marking



## Unit in mm



Weight: 0.012g

### ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Transition Frequency	$ m f_{T}$	$V_{CE}=10V, I_{C}=10mA$	_	3.5	_	GHz
Insertion (fair	$ S_{21e} ^2$ (1)	$V_{CE} = 10V, I_{C} = 10mA, f = 500MHz$	_	14.5	_	dB
	$ S_{21e} ^2$ (2)	$V_{CE}=10V, I_{C}=10mA, f=1GHz$	_	9	_	dB
Noise Figure $\frac{NF(1)}{NF(2)}$	NF (1)	$V_{CE}=10V$ , $I_{C}=5mA$ , $f=500MHz$	_	2.5	_	dB
	NF (2)	$V_{CE}=10V$ , $I_{C}=5mA$ , $f=1GHz$		3	_	dB

#### ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	$I_{ m CBO}$	$V_{CB} = 10V, I_{E} = 0$	_	_	1	$\mu$ A
Emitter Cut-off Current	$I_{ m EBO}$	$V_{EB}=1V, I_{C}=0$	_	_	1	$\mu$ A
DC Current Gain	$_{ m h_{FE}}$	$V_{\text{CE}} = 10 \text{V}, I_{\text{C}} = 10 \text{mA}$	30	80	300	_
Collecter Output Capacitance	$\mathrm{C_{ob}}$	$V_{CB} = 10V, I_{E} = 0,$	_	1.15	_	pF
Reverse Transfer Capacitance	$\mathrm{C_{re}}$	f = 1MHz (Note)	_	0.75	_	pF

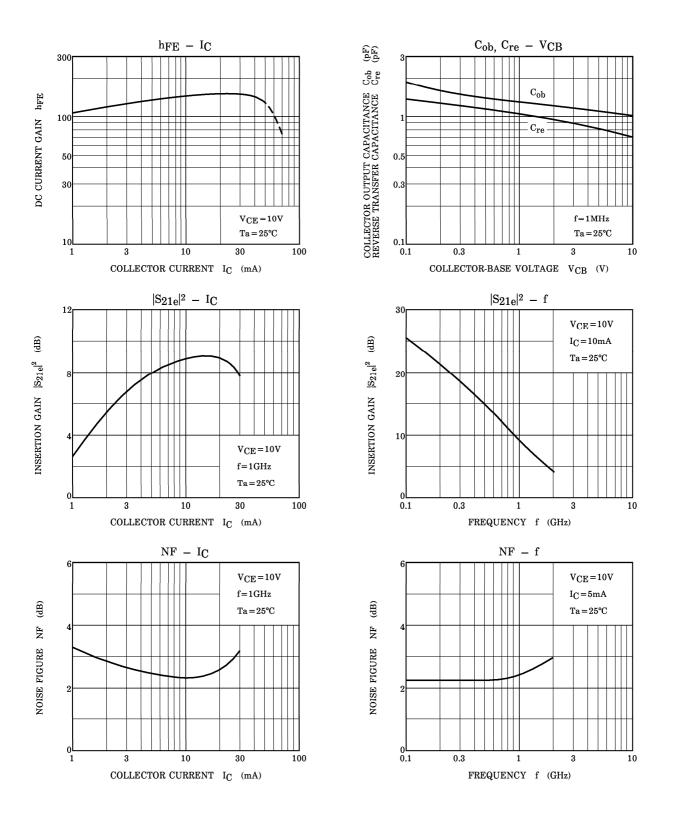
## (Note) Cre is measured by 3-terminal method with Capacitance Bridge.

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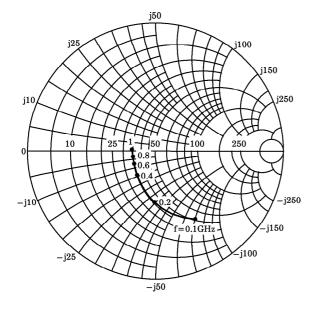
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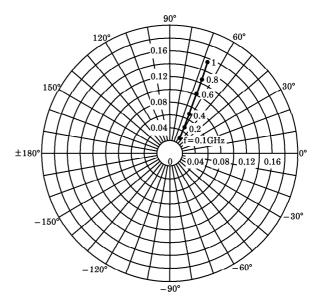
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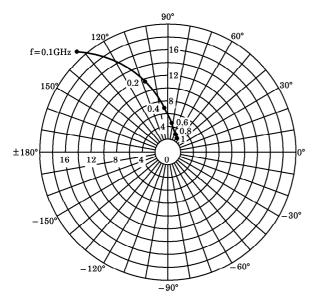


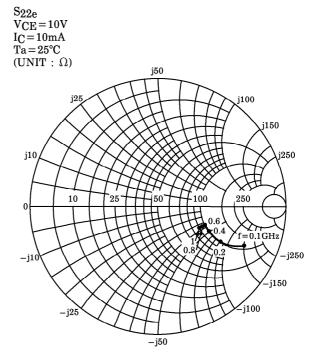
 $\begin{array}{l} {\rm S}_{12e} \\ {\rm V}_{CE}\!=\!10{\rm V} \\ {\rm I}_{C}\!=\!10{\rm mA} \\ {\rm Ta}\!=\!25^{\circ}\!{\rm C} \end{array}$ 





 $\begin{array}{c} {\rm S}_{\rm 21e} \\ {\rm V}_{\rm CE} \! = \! 10{\rm V} \\ {\rm I}_{\rm C} \! = \! 10{\rm mA} \\ {\rm Ta} \! = \! 25^{\circ}{\rm C} \end{array}$ 





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